This application note describes how to properly interface SDRAM memory to the LPC1800 and LPC4300 External Memory Controller.
Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com
1. Introduction

The LPC18xx and LPC43xx 32-bit microcontroller families were designed for embedded applications requiring high performance and low power consumption. The LPC43xx is a dual-core microcontroller implementing an ARM Cortex-M4 and an ARM Cortex-M0 core. The ARM Cortex-M4 is used as application processor. The second core, the ARM Cortex-M0, can be used as co-processor to off-load the ARM Cortex-M4 and to perform serial I/O tasks. The LPC18xx is a single core microcontroller implementing an ARM Cortex-M3 core. The LPC18xx/43xx include an on-chip SRAM, a quad SPI Flash Interface (SPIFI), advanced configurable peripherals such as the State Configurable Timer (SCT), two High-speed USB controllers, Ethernet, LCD, an external memory controller, and multiple digital and analog peripherals. The LPC43xx operate at CPU frequencies of up to 204 MHz, while the LPC18xx operate at CPU frequencies of up to 180 MHz.

The LPC43xx and LPC18xx use the same External Memory Controller (EMC), an ARM PrimeCell MultiPort Memory Controller peripheral offering support for asynchronous static memory devices such as RAM, ROM and Flash, as well as dynamic memories such as Single Data Rate (SDR) SDRAM. For microcontroller external memory of 2 MB or larger the SDR SDRAM is one of the most practical memories to use today.

This application note will focus on interface connectivity and board layout guidelines when using SDR SDRAM memories with the LPC18xx/43xx microcontrollers.

The LPC18xx or LPC43xx user manuals will be referenced in this application note, so keep the corresponding user manual (LPC18xx UM10430; LPC43xx UM10530) at hand.
2. External Memory Controller (EMC)

The LPC18/43xx EMC is an ARM PrimeCell MultiPort Memory Controller peripheral offering support for asynchronous static memory devices such as RAM, ROM and Flash, as well as dynamic memories such as SDR SDRAM. The EMC does not support double data rate (DDR) SDRAMs, or synchronous static memory devices (synchronous burst mode).

2.1 EMC signals

The EMC supports up to a 32-bit data bus, depending on which device package is used. The EMC supports a 16-bit or 32-bit wide data interface built from 8, 16 or 32-bit SDRAM chips. The static memory data bus may be 8-bit, 16-bit or 32-bit when mixed with SDRAM. The EMC signals are multiplexed at the chip port pins with other functions. Some EMC functions are available only at a single port pin while others are available at multiple port pins. The selection of which port pin to use may depend on what other chip peripherals will be used. Use the appropriate data sheet to select the required EMC functions for SRAM and SDRAM support. The EMC functions required for interfacing with SDRAM and SRAM are listed in Table 1.

Table 1. EMC signals

<table>
<thead>
<tr>
<th>EMC signal</th>
<th>Static RAM function</th>
<th>SDRAM function</th>
<th>Notes</th>
</tr>
</thead>
<tbody>
<tr>
<td>EMC_A12:0</td>
<td>Memory address</td>
<td>Row / column address</td>
<td>A0, A9:6 also used for boot mode select.</td>
</tr>
<tr>
<td>EMC_A14:13</td>
<td>Memory address</td>
<td>Bank</td>
<td>EMC_A13 to Bank0; EMC_A4 to Bank1.</td>
</tr>
<tr>
<td>EMC_A23:15</td>
<td>Memory address</td>
<td>-</td>
<td>Not used with SDRAM.</td>
</tr>
<tr>
<td>EMC_D31:0</td>
<td>Data</td>
<td>Data</td>
<td>SRAM 8-bit, 16-bit, 32-bit; SDRAM 16-bit, 32-bit.</td>
</tr>
<tr>
<td>EMC_OE</td>
<td>Output enable strobe</td>
<td>-</td>
<td>Active low, not used with SDRAM</td>
</tr>
<tr>
<td>EMC_BLS3:0</td>
<td>Byte lane select / byte write enable</td>
<td>-</td>
<td>Active low. Specific behavior is controlled by STATICCON[0:3] register PB bit.</td>
</tr>
<tr>
<td>EMC_CS3:0</td>
<td>Chip select</td>
<td></td>
<td>Active low, not used with SDRAM</td>
</tr>
<tr>
<td>EMC_WE</td>
<td>Write enable</td>
<td>Write enable</td>
<td>Active low. Defines command to SDRAM. SRAM Specific behavior is controlled by STATICCON[0:3] register PB bit.</td>
</tr>
<tr>
<td>EMC_DYCS3:0</td>
<td>-</td>
<td>Chip select</td>
<td>Active low. Reference the user manual for AHB address range for each select space. Not used with SRAM.</td>
</tr>
<tr>
<td>EMC_CKEOUT3:0</td>
<td>-</td>
<td>Clock enable</td>
<td>Active low, one for each DYCS. Not used with SRAM.</td>
</tr>
<tr>
<td>EMC_CAS</td>
<td>-</td>
<td>Column address strobe</td>
<td>Defines command to SDRAM along with RAS, WE and DYCS. Not used with SRAM.</td>
</tr>
</tbody>
</table>
### EMC clocking to SDRAM

There are two clock options for the EMC_CCLK. For the LPC18xx either BASE_M3_CLK or 1/2 x BASE_M3_CLK core clock may be used. For the LPC43xx the BASE_M4_CLK or 1/2 x BASE_M4_CLK core clock may be used. If the EMC_CCLK is configured for 1/2 x BASE_M3_CLK or 1/2 x BASE_M4_CLK, the CLK_M3_EMC_DIV or CLK_M4_EMC_DIV branch clock must be configured for half-frequency clock operation in both the CREG6 register and the CCU1 CLK_EMCDIV_CFG register.

At the SDRAM, all input signals are sampled on the positive edge of the clock pin. The clock pin also increments the SDRAM internal burst counter and controls the output registers.

#### 2.2.1 EMC_CLK3:0 signal pin configuration

The EMC dynamic memory interface has four clocks (EMC_CLK3:0), one for each EMC data byte lane. The EMC may be configured for either a 16-bit wide or 32-bit wide SDRAM system memory. The EMC_CLK3:0 signals are output on pins CLK3:0. It is essential that all four EMC_CLK3:0 signals get fed back to the EMC block for the SDRAM interface to read data from the SDRAM correctly. To use SDRAM, regardless of the EMC data width, you must have all four byte lane feedback clocks configured in the System Control Unit (SCU). You may use all four CLKx pins, one for each EMC_CLKx signal, by setting SFSCLKx mode to function 0 (see Fig 1). Alternatively, SFSCLK0 may be configured for combined EMC_CLK01 (function 5), and SFSCLK2 may be configured for combined EMC_CLK23 (function 5), as shown in Fig 2. When CLK0 and CLK2 pins are configured for function 5, CLK1 and CLK3 pins may be used to drive the SDRAM clock pin, or used for a function other than the EMC_CLK. The mapping between the CLKx pin and EMC_CLKx signal and typical settings for SFSCLKx register are shown in Table 2. The common CLKx pin combinations used for SDRAM configurations are shown in Fig 3.
Table 2. CLKx pin configuration

<table>
<thead>
<tr>
<th>Pin name</th>
<th>EMC_CLK</th>
<th>SFSCLK:Mode</th>
<th>ZIF, EZI, EHS, EPUN, EPD</th>
</tr>
</thead>
<tbody>
<tr>
<td>CLK0</td>
<td>EMC_CLK0</td>
<td>Function 0</td>
<td>1, 1, 0, 1, 0</td>
</tr>
<tr>
<td>CLK0</td>
<td>EMC_CLK01</td>
<td>Function 5</td>
<td>1, 1, 0, 1, 0</td>
</tr>
<tr>
<td>CLK1</td>
<td>EMC_CLK1</td>
<td>Function 0</td>
<td>1, 1, 0, 1, 0</td>
</tr>
<tr>
<td>CLK2</td>
<td>EMC_CLK3</td>
<td>Function 0</td>
<td>1, 1, 0, 1, 0</td>
</tr>
<tr>
<td>CLK2</td>
<td>EMC_CLK23</td>
<td>Function 5</td>
<td>1, 1, 0, 1, 0</td>
</tr>
<tr>
<td>CLK3</td>
<td>EMC_CLK2</td>
<td>Function 0</td>
<td>1, 1, 0, 1, 0</td>
</tr>
</tbody>
</table>

(1) No CLKx pin can be used for a function other than EMC_CLK.

Fig 1. Individual CLK pin used for read data capture feedback clocks
(1) CLK1 and CLK3 may be used to drive SDRAM clock pin even though not used as read data feedback clock. SFSCLK1/3: EZI = 0.

(2) CLK1 and CLK3 may be used for a function other than EMC_CLK.

(3) CLK0 and CLK2 must be configured for combined EMC_CLK function.

Fig 2. Combined EMC_CLK on CLK0 and CLK2 used for read data feedback clocks
Common CLKx configurations; see Section 2.3 for better performance configurations.

Fig 3. Common CLKx pin to SDRAM configurations
2.2.2 EMC output signal timing to SDRAM

At the SDRAM, all input signals are sampled on the positive edge of the clock pin. The Dynamic memory read configuration register DYNAMICREADCONFIG:RD together with the EMC clock delay register (EMCDELAYCLK) are used to ensure proper setup and hold times for EMC signals registered by the SDRAM. With the Dynamic Memory Read Configuration register DYNAMICREADCONFIG:RD = 0x1, all EMC signals, except the CLkx and CKEx, are delayed by 1/2 EMCCCLK period. This means the EMC output signals change within a few nanoseconds after the falling edge of the internal EMCCCLK, providing setup for the SDRAM to latch the command or data on the next rising edge of external EMC CLkx, as shown in Fig. 4. The EMC clock delay register EMCDELAYCLK (0x40086D00) provides a programmable delay for the EMC_CLKx outputs. Generally, the delay for all EMC_CLKx outputs should be set the same, even if they aren’t all going to an SDRAM. The CLKDLYx increases approximately 0.5 ns for each step from 0 (CLK_DELAY = 0) to 3.5 ns (CLK_DELAY = 0x00007777). The exact values of the delays vary over temperature and processing. It is recommended that EMCDELAYCLK be set to the lowest value necessary to meet the SDRAM minimum setup timing.

![EMC output signal timing](Image)

Fig 4. EMC output signal timing

2.2.3 EMC signal capture read data timing from SDRAM

The EMC supports a 32-bit or 16-bit wide data interface built from x8, x16 or x32-bit SDRAM devices. The external data width and organization will determine which feedback clocks (FBCLKx) the EMC uses to pack the data in 32b words (see Table 3). Note that even when a single CLkx pin is used to drive a single SDRAM clock, at minimum CLk0 and CLk2 pins are used to feedback byte lane clocks for capturing read data from the SDRAM. The input buffer enable (EZI) must be set in the SFSCLKx pin configuration register for the pin to source a feedback clock. The timing from the EMC issuing the read command to the SDRAM to the first word of a read burst from the SDRAM captured at the EMC is shown in Fig. 5. The CAS latency is generally three SDRAM clock cycles. The same number of CAS latency clock cycles must match between the EMC Dynamic Memory RASCAS Delay registers DYNAMICRASCASx:CAS and the SDRAM Mode register CAS field. See the LPC18xx/43xx user’s manual for a detailed example of what value to set the SDRAM mode register, and how to calculate the mode register address.
Table 3. Read Data feedback clock mapping

<table>
<thead>
<tr>
<th></th>
<th></th>
<th></th>
<th></th>
<th></th>
</tr>
</thead>
<tbody>
<tr>
<td>32b (4x8b) [1]</td>
<td>EMC_CLK3</td>
<td>EMC_CLK2</td>
<td>EMC_CLK1</td>
<td>EMC_CLK0</td>
</tr>
<tr>
<td>32b (2x16b) [2]</td>
<td>EMC_CLK23</td>
<td>EMC_CLK23</td>
<td>EMC_CLK01</td>
<td>EMC_CLK01</td>
</tr>
<tr>
<td>16b (2x8b) [2]</td>
<td>EMC_CLK23</td>
<td>EMC_CLK23</td>
<td>EMC_CLK01</td>
<td>EMC_CLK01</td>
</tr>
</tbody>
</table>

[1] Use SFSCLK pin configuration mode function 0 for CLK0, CLK1, CLK2, CLK3.
[2] Use SFSCLK pin configuration mode function 5 for CLK0, CLK2. Pins CLK1 and CLK3 may be used for alternate function.
[3] These CLKx pins must have EZI = 1 in the SFSCLKx register, but are not connected to SDRAM.
[4] When using EMC_CLK_DIV2 mode with a single x16 or x32 SDRAM device, connecting CLK1 or CLK3 to the SDRAM may allow higher EMC clock speed. See section 2.2.5.2 for additional details.

2.2.4 Compensating for signal flight time delay

The time delay between the EMCCCLK launched from the LPC43xx/18xx pin and a valid clock signal voltage arrival at the SDRAM is called flight time. Similarly, there is flight time between data being launched from the SDRAM and the signal reaching valid voltage level at the EMC. A 50 ohm PCB trace has approximately 1 ns of delay for every 6” of length. The data set-up time for read data captured at the EMC is reduced by the flight time of the EMCCCLK to the SDRAM and the read data flight time from the SDRAM to EMC. With the EMC_CLK at 102 MHz there is usually enough margin in the data setup time at the EMC for this flight time to be ignored. However, if the SDRAM is placed such that the flight time delay causes the read data to no longer arrive at the EMC early enough to meet the LPC43xx/18xx data input set-up time, either the EMCCCLK speed needs to be reduced, or the EMC feedback clock delay register can be used to compensate for the flight time.

2.2.4.1 EMC feedback clock delay register

This register provides a programmable delay for the EMC feedback clocks (8 data lanes per feedback clock). The delay for each control output is approximately 0.5 ns x XXX_DELAY. (XXX_DELAY = 0x0 = 0 ns, 0x1: delay ∼ 0.5 ns, … 0x7: delay ∼ 3.5 ns.)
The feedback clock delay register EMCFBCLKDELAY is found at address 0x40086d10. FBCLK0_DELAY defined in bits 2:0, FBCLK1_DELAY defined in bits 6:4, FBCLK2_DELAY defined in bits 10:8, FBCLK3_DELAY defined in bits 14:12. At reset all feedback delay bits are 0. All FBCLKx_DELAYs are generally set to the same value.

2.2.5 Core clock divide by 2

When 1/2 x BASE_M4_CLK core clock (EMC_CLK_DIV) is used (also applies to 1/2 x BASE_M3_CLK), the EMC_CLKx duty cycle may become unsymmetrical where the high period is stretched longer and the low period becomes shorter. Since the EMC signals are launched from EMC on the falling edge of the EMC_CLK, the impact of the shorter low period is the EMC signals will have less setup time before the next rising edge of EMC_CLKx where they are registered by the SDRAM. When using EMC_CLK_DIV2 the EMCDELAYCLK value may need to be increased to obtain the same setup time provided when using the BASE_M4_CLK. For chip revisions that have an unsymmetrical EMC_CLKx duty cycle when operating in 1/2 x BASE_Mx_CLK core clock mode, setting the EMCDELAYCLK value for all CLKx between 4 and 6 works best. Refer to chip errata sheet ES_LPC43x0 or ES_LPC18x0 section EMC.1 to determine if the chip revision you’re using will have an unsymmetrical EMC_CLKx duty cycle.

2.2.5.1 Maximum EMC_CLKx speed vs trace length

When using a CLKx pin to drive the SDRAM clock, and also as the feedback clock for capturing SDRAM read data, the maximum EMC speed will be determined by the round trip delay of the CLKx signal. This would apply to any of the common EMC clock configurations shown in Fig. 3. This is due to the way the source impedance of the high speed / high slew rate buffer driver and the PCB trace characteristic impedance together create a voltage divider at the pad of the CLKx signal, where the full signal swing at the CLKx pin receiver only occurs after the clock signal has propagated to the end of the PCB trace and has reflected back to the receiver. As a worst case example, when using the core clock divide by 2 mode with a chip revision having an unsymmetrical EMC_CLKx duty cycle and 6” of PCB trace length (having approximately 2 nS round-trip delay), the maximum functional EMC clock speed will be approximately 100 MHz (core speed 200 MHz).

2.2.5.2 Solution to achieve full system core / EMC clock speed (204 / 102 MHz)

The key to running the EMC at full speed is to use EMC_CLK01 (CLK0 pin with SFSCCLK0 = function 5) and EMC_CLK23 (CLK2 pin with SFSCCLK2 = function 5) for the four byte lane feedback clocks, while using EMC_CLK1 (CLK1 pin) and / or EMC_CLK2 (CLK3 pin) to drive the SDRAM clocks. LPC18/43xx pins CLK0/2 remain floating or connected to short PCB traces for access test points and therefore have immediate full swing signal at the feedback clock receiver input. Since CLK1 and CLK3 are not being used as feedback clocks their length may exceed the 6” restriction without affecting the feedback clocks for capturing SDRAM read data. For an example of using this solution with a single x16 or x32 SDRAM see Fig. 6 and Fig. 7. For an example using two x16 SDRAMs see Fig. 8.

1. For a better understanding of this behavior see “Right the First Time, A practical handbook on high speed PCB and system design”, Volume one, chap 17, Lee Ritchey, 2003.

2.2.5.3 Best performance using a single SDRAM device and CCLK Div2

When using a single SDRAM, x16 or x32, a single CLKx pin is connected between the EMC and the SDRAM as shown in Fig 6. However, all four EMC feedback clocks (EMC_FBCLKx) are needed for capturing read data from the SDRAM (see section 2.2.3 for details). See section 2.6 for recommended termination near the SDRAM.

![Fig 6. Best performance CCLK Div2 single SDRAM configuration](image)

(1) Do not use CLK0 or CLK2 for any other function.
(2) EMC_CLK3 (CLK3 pin) may be used instead of CLK1.

2.3 EMC to SDR SDRAM connections

The LPC32x0 EMC supports either a 16-bit wide or 32-bit wide system SDR SDRAM bus. The system SDR SDRAM bus may be constructed with:

- one 32-bit wide SDR SDRAM
- one or two 16-bit wide SDR SDRAMs
- two or four 8-bit wide SDR SDRAMs

Using a single x32 SDR the maximum memory for each EMC_DYCS[3:0] is 64 MB (16M x 32). Using two x16 SDRs the maximum memory for each EMC_DYCS[3:0] is 128 MB (two 32M x 16). Using four x8 SDRs the maximum memory for each EMC_DYCS[3:1] is 256 MB (four 64M x 8). Using x8 SDRAMs is not recommended, as this is not usually a cost effective configuration, and the higher capacitive loading on the EMC address and control signals, which go to all SDRAMs, may reduce the maximum operational speed of the interface.

2.3.1 Recommended configurations using single DYNCSx

Most applications will require only a single dynamic chip select (DYNCSx). EMC performance may be compromised when PCB traces are longer than 6” or capacitive loads exceed those listed in the datasheet under dynamic characteristics, Dynamic external interface. Using a single SDRAM with either an x16 or x32 data bus will provide minimum loading to the EMC, resulting in maximum EMC performance. The detailed connections using a single x32 SDRAM are shown in Fig 7. When using two x16 SDRAMs to form a 32-bit wide EMC data bus the recommended connections are shown
In Fig 8, an alternate configuration using two x16 SDRAMs, which frees pins CLK1 and CLK3 to be used for other functions, is shown in Fig 9. However, when using the configuration in Fig 9 using chip revisions having EMC.1 errata operating in CCLK DIV2 mode, we recommend limiting CLK0 or CLK2 trace length to no more than 6” or reducing the EMC_CLKx frequency to less than 102 MHz. Longer CLK0/CLK2 traces result in a lower maximum EMC clock frequency.

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### Fig 8

**Single SDRAM x32 data bus**

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<table>
<thead>
<tr>
<th>LPC18/43xx</th>
<th>SDRAM</th>
</tr>
</thead>
<tbody>
<tr>
<td>EMC_D31:24</td>
<td>DQ31:24</td>
</tr>
<tr>
<td>EMC_DQM3</td>
<td>DQM3</td>
</tr>
<tr>
<td>EMC_D23:16</td>
<td>DQ23:16</td>
</tr>
<tr>
<td>EMC_DQM2</td>
<td>DQM2</td>
</tr>
<tr>
<td>EMC_D15:8</td>
<td>DQ15:8</td>
</tr>
<tr>
<td>EMC_DQM1</td>
<td>DQ17:8</td>
</tr>
<tr>
<td>EMC_D7:0</td>
<td>DQ7:0</td>
</tr>
<tr>
<td>EMC_DQM0</td>
<td>DQ0</td>
</tr>
<tr>
<td>EMC_A14</td>
<td>BA1</td>
</tr>
<tr>
<td>EMC_A13</td>
<td>BA0</td>
</tr>
<tr>
<td>EMC_A12:0</td>
<td>A12:0</td>
</tr>
<tr>
<td>EMC_DYCSx</td>
<td>nDYCSx</td>
</tr>
<tr>
<td>EMC_CKE</td>
<td>CKE</td>
</tr>
<tr>
<td>EMC_RAS</td>
<td>nRAS</td>
</tr>
<tr>
<td>EMC_CAS</td>
<td>nCAS</td>
</tr>
<tr>
<td>EMC_WE</td>
<td>nWE</td>
</tr>
<tr>
<td>EMC_CLK1</td>
<td>CLK1</td>
</tr>
<tr>
<td>EMC_CLK23</td>
<td>CLK2</td>
</tr>
<tr>
<td>EMC_CLK01</td>
<td>CLK0</td>
</tr>
</tbody>
</table>

(1) CLK0 and CLK2 are the source for feedback clocks (SFSCCLKx mode = function 5), and must not be used for anything else.

(2) CLK1 has SFSCCLK1 mode = function 0, EZI = 0.

(3) CLK3 may be used for SDRAM clock instead of CLK1 or may be used for alternate function.

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**Fig 7** Single SDRAM x32 data bus
Fig 8. Recommended connections for two 16-bit SDRAMs forming 32-bit EMC data bus

1. CLK0 and CLK2 are the source for feedback clocks (SFCLKx mode = function 5), and must not be used for anything else.

2. CLK1 and CLK3 (SFCLK1, SFCLK3 mode = function 0, EZI = 0).
2.3.2 Recommended configuration using multiple DYNCSx

When the application requires more external memory capacity than can be supplied by a single 32-bit SDRAM, it is recommended to use x16 or x8 SDRAMs to build a 32-bit EMC data bus on a single DYNCS. This is recommended so the data bus, broken in to byte lanes, only goes to a single SDRAM. However, multiple dynamic chip selects may be used when more system memory is required than can be supported by a single chip select. When using multiple DYNCSs, in addition to the address and control signals, the data bus must go to multiple SDRAMs as well. Connecting two 32-bit SDRAMs is shown in **Fig 10**. An alternate configuration using two x32 SDRAMs which frees pins CLK1 and CLK3 for other functions similar to using two x16 SDRAMs is also possible, but chip revisions with EMC.1 errata should keep CLK0 and CLK2 trace length less than 6” when used in CCLK DIV 2 mode or operate the EMC_CLKx at a reduced rate. Refer to ES_LPC43x0 or ES_LPC18x0 for additional details.
2.3.3 Special consideration for EMC pins shared with boot select

Port pins P2_7, P2_8, P2_9, P1_2 and P1_1 are used as EMC address signals, and also used for setting the ISPEN (P2_7) and LPC18/43xx boot mode (P2_8, P2_9, P1_2, P1_1). The ISPEN and boot mode select signals are generally available at headers, switches, or pull-up/down resistors on the PCB, and they may not be located near the SDRAM. The trick is to isolate the length of trace from the corresponding EMC address bit along the EMC bus from the ISPEN or boot select circuit with a 4.7 kΩ series resistor, as shown in Fig 11.
2.4 EMC bus PCB layout topology

EMC CLKx signals should be routed using point-to-point routing topology. When multiple SDRAMs are needed, use one CLKx pin to drive one SDRAM. For a design that requires more than four SDRAMs, each CLKx pin may have two SDRAM clocks connected by a daisy-chain, placing one SDRAM at the end of the daisy-chain and the other no more than 1” from the end of the daisy-chain, keeping any branch stub to 0.5”. EMC signals that go to multiple devices, excluding CLKx pins, should be routed in a daisy-chain with branch stubs no longer than 2”.

It is possible to route the EMC CLK and other signals in a star topology, but that requires each PCB trace in the star to be length matched to each other, and each PCB trace characteristic impedance be a little more than twice the source impedance of the EMC IO buffer. It is strongly recommended to use star topology routing only after using LPC18xx/43xx and SDRAM Ibis models along with signal integrity software to simulate your design.

2.4.1 Shared EMC configuration

The EMC bus can be shared by multiple devices, such as SDRAM, nor-Flash, SRAM or devices with an SRAM-type interface. Below is a list of key items to follow when the design requires EMC bus to be shared.

- Route the EMC bus in a daisy-chain topology.
- In daisy-chain topology place the LPC18xx/43xx at one extreme end of the daisy-chain and the SDRAM at the other extreme end. Other devices can be distributed along the daisy-chain, see Fig 12.
- If more than four devices total (including the SDRAM and LPC18/43xx) are connected to the EMC bus, it is recommended you connect only the SDRAM and bidirectional bus buffers to the LPC18xx/43xx EMC directly, then connect the other devices to the buffered side of the EMC bus, see Fig 13.
• If the EMC is used for SDRAM and expanding connections off the LPC18xx/43xx board, bi-directional bus buffers must be used to isolate the off-board EMC from the SDRAM interface. The SDRAM must be connected directly to the un-buffered EMC bus, see Fig 13. An example of buffering the EMC bus is shown in Fig 14.

• The EMC CLKx routes must be point-to-point. Any test points placed on the CLKx routes should be placed within 1" of the SDRAM. Daisy-chaining two SDRAMs on one CLKx pin is possible, see section 2.4.
The example can be expanded to 32-bit data and also having additional address and control bits by adding more 74LVC16245 buffers.

Fig 14. EMC buffer schematic example

2.5 EMC PCB trace impedance recommendation

The EMC CLKx pins are driven by a high-speed IO buffer. To run the EMC above 75 MHz the LPC18/43xx CLKx pins must be configured for high-speed slew rate (SFSClkx:EHS = 0b1), generating rise / fall times of 350 ps to 700 ps. The CLKx pin source impedance is typically 50 Ω, and matches well to a PCB trace with a characteristic impedance of 60 Ω to 80 Ω without the need for any additional series termination near the LPC18/43xx. All other EMC pins have a normal drive strength buffer output, and must have the slew rate set to fast speed (SPSPx:x:EHS = 0b1), generating rise / fall times of 1 ns to 2.5 ns. For all EMC pins, other than CLKx, it is recommended to use a PCB trace with a characteristic impedance of 80 Ω to 100 Ω with no external series termination near the EMC pin.

2.6 EMC bus terminations

The LPC18xx/43xx EMC IO buffer’s internal source impedance matches well to 60 Ω to 100 Ω PCB trace characteristic impedance. In other words, the series source termination is built-in to the IO buffer, so no termination resistor is needed near the EMC pin.

All single data rate 3 V SDRAM data IO buffers have very strong, low impedance drive strength and no internal drive strength reduction control, resulting in very fast rise and fall times. When the total EMC data bus trace length for any individual data signal is longer than 1.5”, it is recommended that series source termination be place near the data pins of all SDRAM chips in the design. This will minimize the over-shoot and under-shoot associated with data driven by the SDRAM, also reducing the electro-magnetic interference (EMI) when the SDRAM is driving the EMC data bus.

2.7 EMC SDRAM PCB routing rules

Generally, keeping the EMC data bus signals as short as possible and capacitive loading to a minimum is the best practice. Using the rules below as a guide will help ensure proper SDRAM timing is achieved.
Rule 1: At each SDRAM match EMC_Data[31:0], EMC_DQM[3:0], EMC_A[14:0], EMC_RAS, EMC_CAS, EMC_DYCS[3:0]_N, EMC_WR_N, EMC_CKE[3:0] to within 2” of each other. Since signals require the reflected wave to reach full signal swing, for purposes of the length matching calculation, this is from the LPC18/43xx to the end of the daisy-chain trace (incident wave) plus the distance from the end of the daisy-chain back to the SDRAM pin (reflected wave).

Example calculating effective trace length for matching purposes, reference Fig 15:

Assume Signal 1 length between LPC18/43xx and SDRAM “A” = 3”
Assume Signal 1 length between SDRAM “A” and SDRAM “B” = 2”
Assume Signal 2 length between LPC18/43xx and SDRAM “A” = 2”
Assume Signal 2 length between SDRAM “A” and SDRAM “B” = 2”

The calculation for each signal trace length matching is as follows:

Signal 1 at SDRAM “B” = 3” + 2” = 5”; overall length of the daisy-chain; incident wave.

Signal 2 at SDRAM “B” = 2” + 2” = 4”; overall length of the daisy-chain; incident wave.

Signal 1 at SDRAM “A” = “3” + 2” + 2” = 7”; incident wave + reflected signal back to SDRAM.

Signal 2 at SDRAM “A” = 2” + 2” + 2” = 6”; incident wave + reflected signal back to SDRAM.

Rule 2: Any EMC CLKx that’s connected to an SDRAM clock should be kept under 6” when also used to provide the feedback clock for SDRAM read data capture, reference section 2.2.5.1. The CLKx trace can be kept short and does not have to match length to other EMC signals. The EMC_CLKx can be delayed by the EMCDELAYCLK register as necessary to provide the proper SDRAM setup / hold timing, see section 2.2.2.

2.8 Example PCB layer stackup

Stackup is a term used to describe the physical arrangement of the layers in a PCB. For any high-speed design the two key elements determined by the stackup are transmission line impedance and inter-plane capacitance. Any board design that uses SDRAM should use a PCB stackup that includes power and ground planes. Pairing each signal layer with an adjacent plane layer (either power or ground) will improve impedance control for each signal layer. The two key dimensional characteristics of the trace affecting impedance value are the height to the nearest plane layer and the trace width. There are sources for
trace impedance calculators available on the internet which can be used to help you get your design near the target trace impedance. However, it’s always best to work closely with your board fabrication supplier, and indicate on your supplied board fabrication drawing what nominal impedance value is desired for each trace width which needs to be impedance controlled. Trace impedance and velocity of propagation are also controlled by the dielectric constant of the insulating material used for the PCB. There are a number of materials used for PCB dielectrics, however FR4 is probably the most common low cost dielectric material used for PCBs. An example of a six-layer PCB stackup is shown in Fig 16. The example assumes FR4 (high-tg), having a dielectric constant (er) of 4.7, where signal layers 1, 3, 4 and 6 with 0.007” trace width have a nominal characteristic impedance of 65 Ω to 67 Ω, and 0.004” trace width have a nominal characteristic impedance of 80 Ω. One nice thing about this stackup is for any given trace width, no matter which layer it’s routed on, the characteristic impedance stays within a couple of ohms. Using the example stackup, all CLKx signals would be routed with 0.007” trace width and all other EMC signals routed with 0.004” width traces. This example is just one of a number of possible six-layer stackups. Again, we recommend you involve your PCB fabrication supplier early in the board design process to assist in selecting dielectric materials, a board stackup and trace widths to meet the desired trace characteristic impedance goals.

![Fig 16. Example six-layer PCB stackup with 66 Ω and 80 Ω transmission lines](image)

Ground on layer 2 and power on layer 5 are assumed to occupy the full layer.
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